Notice of References Cited

Application/Control No. 10/558,432	Applicant(s)/Pater Reexamination BAEK ET AL.	nt Under
Examiner	Art Unit	
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U.S. PATENT DOCUMENTS

	U.S. PATENT DOCUMENTS				
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,928,245 A	05-1990	Moy et al.	700/218
*	В	US-5,551,001 A	08-1996	Cohen et al.	711/122
*	С	US-5,794,037 A	08-1998	Young, David W.	718/108
*	D	US-5,808,885 A	09-1998	Dew et al.	700/3
*	Е	US-5,859,847 A	01-1999	Dew et al.	370/389
*	F	US-6,078,952 A	06-2000	Fielding et al.	709/221
*	G	US-2002/0118696 A1	08-2002	Suda, Yukinori	370/432
*	Н	US-2002/0120763 A1	08-2002	Miloushev et al.	709/230
*	_	US-2002/0165989 A1	11-2002	Etoh, Hiroshi	709/248
*	J	US-2002/0193144 A1	12-2002	Belski et al.	455/557
*	к	US-2003/0051053 A1	03-2003	Vasko et al.	709/246
*	L	US-2003/0054809 A1	03-2003	Bridges et al.	455/419
*	М	US-6,615,243 B1	09-2003	Megeid et al.	709/208

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
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NON DATENT DOCUMENTS

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Notice of References Cited

Application/Control No.	Applicant(s)/Pater	nt Under
10/558,432	Reexamination BAEK ET AL.	
Examiner	Art Unit	
CHRISTOPHER T. WYLLIE	2465	Page 2 of 2

U.S. PATENT DOCUMENTS

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0111490 A1	06-2004	Im et al.	709/218
*	В	US-2004/0205309 A1	10-2004	Watanabe, Naoki	711/161
*	С	US-6,854,053 B2	02-2005	Burkhardt et al.	713/2
*	D	US-6,934,740 B1	08-2005	Lawande et al.	709/213
*	Е	US-2006/0047677 A1	03-2006	Lin et al.	707/101
*	F	US-7,058,722 B2	06-2006	Ikami et al.	709/231
*	G	US-2008/0222325 A1	09-2008	Ishino et al.	710/60
	Н	US-			
	T	US-			
	J	US-			
	к	US-			
	L	US-			
	м	US-			

FOREIGN PATENT DOCUMENTS

	FOREIGN FATENT DOCUMENTS					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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		NON-PATENT DOCUMENTS
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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